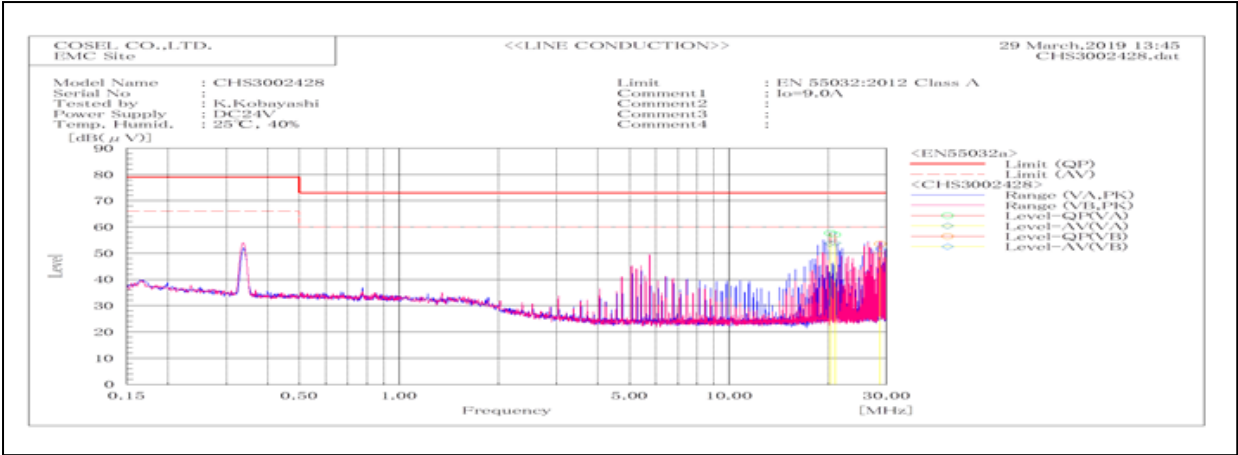
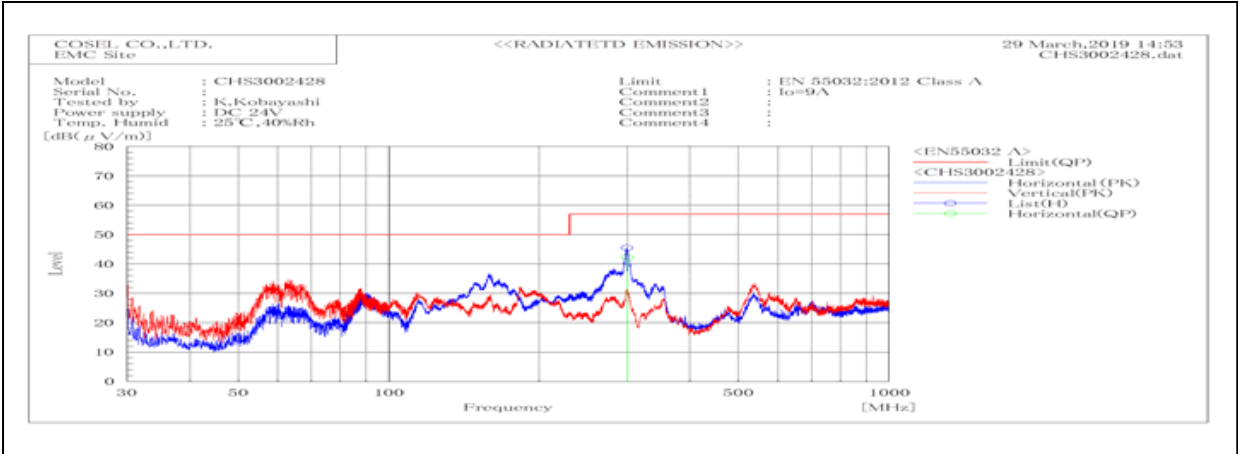


DATA SHEET		Date	29-Mar-19
Model	CHS3002428	Temp.	25 degreeC
Test	EMI Line conduction & Radiated emission	Humid.	40 %RH
		Tested by	K.Kobayashi



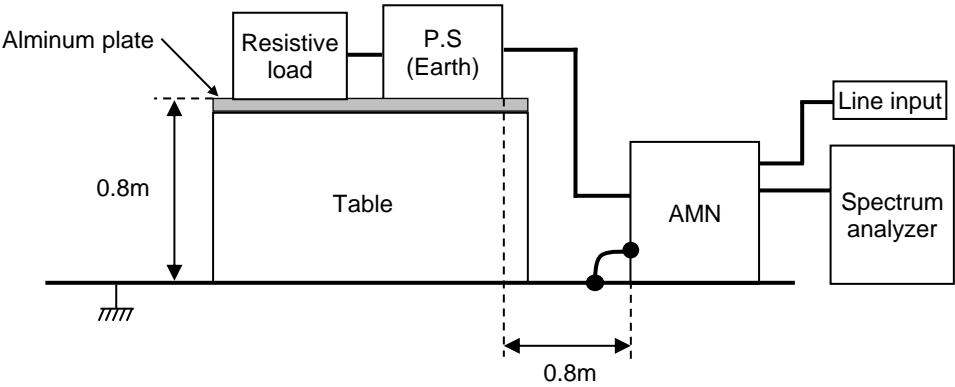
Frequency MHz	Line Phase	Level dB(μV)		Limit dB(μV)		Margin dB		Pass/Fail	Remark
		QP	AV	QP	AV	QP	AV		
20.2632	LA	57.7	53.7	73	60	15.3	6.3	Pass	
20.93515	LA	57.1	53.9	73	60	15.9	6.1	Pass	
28.69615	LB	53.6	51.7	73	60	19.4	8.3	Pass	



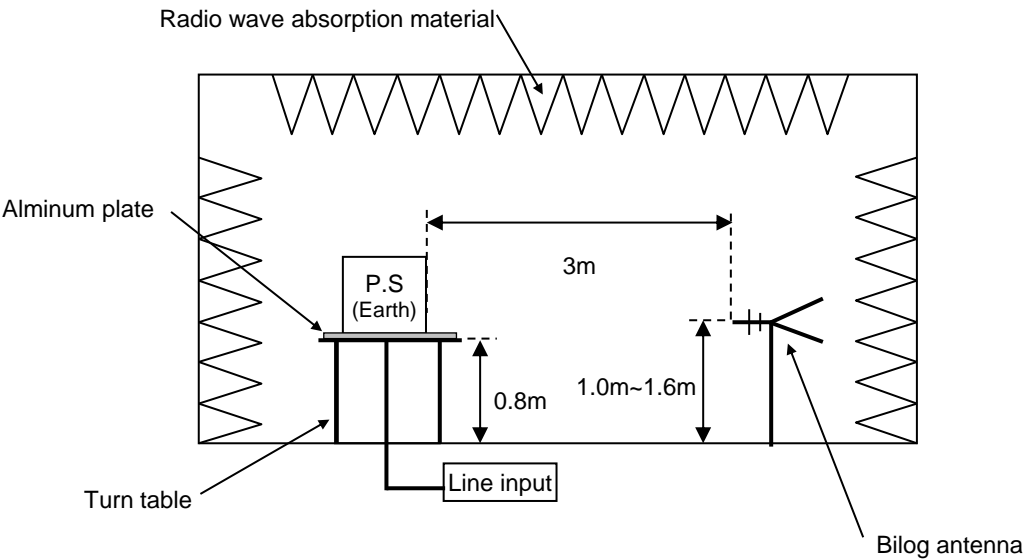
Frequency MHz	Polarization	Stability	Reading dB(μV)	Limit dB(μV/m)	Margin dB(μV/m)	Pass/Fail	Height cm	Angle deg	Remark
			QP	QP	QP				
299.835	H	Stable	42.3	57.0	14.7	Pass	101	299	

DATA SHEET		Date	29-Mar-19
Model	Circuit used for measurement	Temp.	25 degreeC
Test	EMI Line conduction & Radiated emission	Humid.	40 %RH
		Tested by	K.Kobayashi

1. Line conduction



2. Radiated emission



Conditions

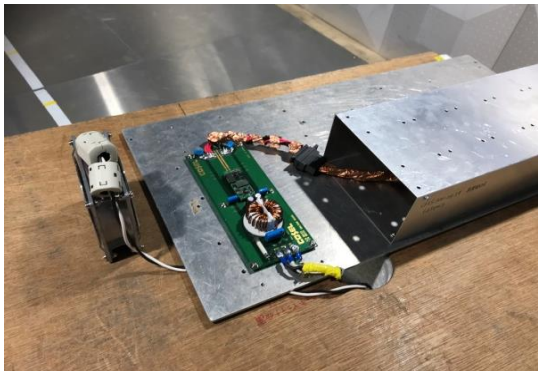
Test : EMI
Model Name : CHS30024□

○Photographs of Test Set-Up

LINE CONDUCTION



RADIATED EMISSION



○Testing circuitry

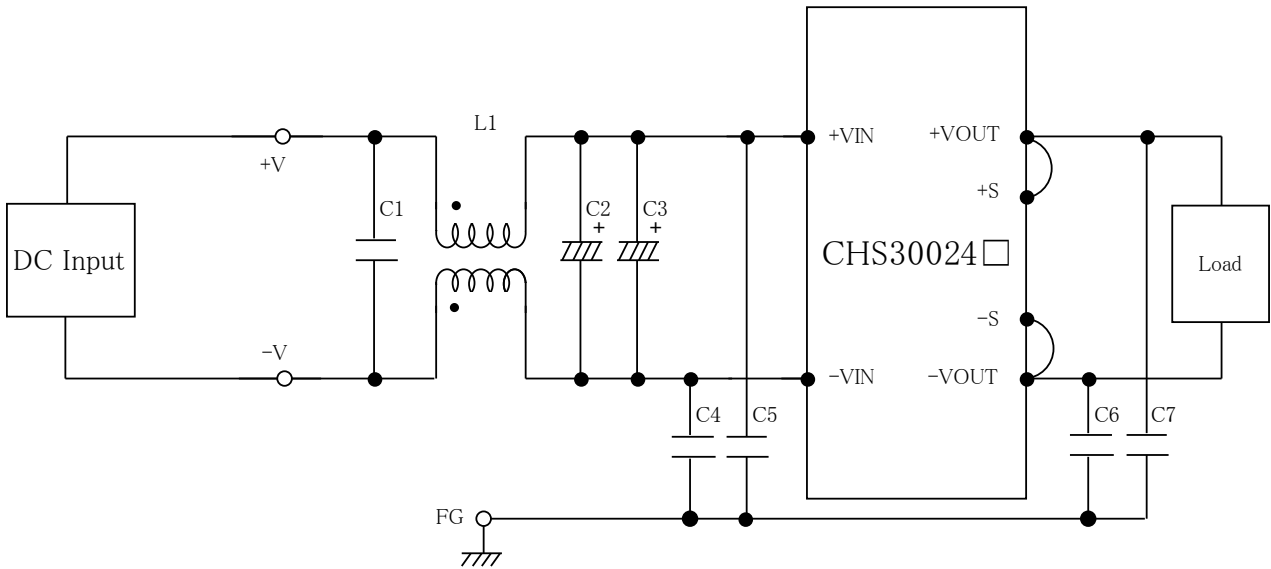


Fig.1 Testing circuitry

- L1 : 1mH SC-20-10JH (TOKIN)
- C1 : 250V 2.2 μ F FPD22E225J4 (NITSUKO)
- C2,C3 : 50V 330 μ F PWseries (nichicon)
- C4,C5 : 630V 0.068 μ F FPD22J683J4 (NITSUKO)
- C6,C7 : 630V 0.033 μ F FPD22J333J4 (NITSUKO)